

Search Notes 	Application/Control No. 10/764,150	Applicant(s)/Patent under Reexamination DUDECK ET AL.
	Examiner Tan T. Nguyen	Art Unit 2827

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
365	203	9/18/2006	TNT
365	94	9/18/2006	TNT
365	104	9/18/2006	TNT